Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/700,119	BECKER ET AL.
Examiner	Art Unit
Ren L. Yan	2854

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Class	Subclass	Date	Examiner
101	239	2/16/05	R-ya
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271	275		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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